Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,231	FAUNCE ET AL.	
Examiner	Art Unit	
Sangwoo Ahn	2166	

Sangwoo Ahn

	SEARCHED					
Class	Subclass	Date	Examiner			
707	2-7	10/25/2006	sw			
			•			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Search History Attached (USPGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB). Text search only	10/25/2006	sw			
Consulted Khanh Pham	10/25/2006	sw			
Consulted Hosain Alam	10/25/2006	SW			
· · · · · · · · · · · · · · · · · · ·					